

# Absolute Maximum Ratings

| Parameter                                                             | IRFM150, JANTXV, JANTX, 2N7224             | Units      |
|-----------------------------------------------------------------------|--------------------------------------------|------------|
| $I_D$ @ $V_{GS} = 10V$ , $T_C = 25^\circ C$ Continuous Drain Current  | 34                                         | A          |
| $I_D$ @ $V_{GS} = 10V$ , $T_C = 100^\circ C$ Continuous Drain Current | 21                                         |            |
| $I_{DM}$ Pulsed Drain Current ①                                       | 136                                        |            |
| $P_D$ @ $T_C = 25^\circ C$ Max. Power Dissipation                     | 150                                        | W          |
| Linear Derating Factor                                                | 1.2                                        | W/K ⑤      |
| $V_{GS}$ Gate-to-Source Voltage                                       | $\pm 20$                                   | V          |
| $E_{AS}$ Single Pulse Avalanche Energy ②                              | 150<br>(See Fig. 12)                       | mJ         |
| $I_{AR}$ Avalanche Current ①                                          | 34<br>(See $E_{AR}$ )                      | A          |
| $E_{AR}$ Repetitive Avalanche Energy ①                                | 15<br>(See Fig. 13)                        | mJ         |
| $dv/dt$ Peak Diode Recovery $dv/dt$ ③                                 | 5.5<br>(See Fig. 13)                       | V/ns       |
| $T_J$ Operating Junction Temperature                                  | -55 to 150                                 | $^\circ C$ |
| $T_{STG}$ Storage Temperature Range                                   |                                            |            |
| Lead Temperature                                                      | 300 (0.063 in. (1.6 mm) from case for 10s) |            |
| Weight                                                                | 9.3 (typical)                              | g          |

## Electrical Characteristics @ $T_J = 25^\circ C$ (Unless Otherwise Specified)

| Parameter                    |                                              | Min. | Typ. | Max.  | Units    | Test Conditions                                                                    |                                                                                                                                                  |
|------------------------------|----------------------------------------------|------|------|-------|----------|------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------|
| $BV_{DSS}$                   | Drain-to-Source Breakdown Voltage            | 100  | —    | —     | V        | $V_{GS} = 0V$ , $I_D = 1.0$ mA                                                     |                                                                                                                                                  |
| $\Delta BV_{DSS}/\Delta T_J$ | Temperature Coefficient of Breakdown Voltage | —    | 0.13 | —     | V/°C     | Reference to 25°C, $I_D = 1.0$ mA                                                  |                                                                                                                                                  |
| $R_{DS(on)}$                 | Static Drain-to-Source On-State Resistance   | —    | —    | 0.07  | $\Omega$ | $V_{GS} = 10V$ , $I_D = 21A$ ④                                                     |                                                                                                                                                  |
|                              |                                              | —    | —    | 0.081 |          | $V_{GS} = 10V$ , $I_D = 34A$                                                       |                                                                                                                                                  |
| $V_{GS(th)}$                 | Gate Threshold Voltage                       | 2.0  | —    | 4.0   | V        | $V_{DS} = V_{GS}$ , $I_D = 250 \mu A$                                              |                                                                                                                                                  |
| $g_{fs}$                     | Forward Transconductance                     | 9.0  | —    | —     | S (⑥)    | $V_{DS} \geq 15V$ , $I_{DS} = 21A$ ④                                               |                                                                                                                                                  |
| $I_{DSS}$                    | Zero Gate Voltage Drain Current              | —    | —    | 25    | $\mu A$  | $V_{DS} = 0.8 \times \text{Max. Rating}$ , $V_{GS} = 0V$                           |                                                                                                                                                  |
|                              |                                              | —    | —    | 250   |          | $V_{DS} = 0.8 \times \text{Max. Rating}$<br>$V_{GS} = 0V$ , $T_J = 125^\circ C$    |                                                                                                                                                  |
| $I_{GSS}$                    | Gate-to-Source Leakage Forward               | —    | —    | 100   | nA       | $V_{GS} = 20V$                                                                     |                                                                                                                                                  |
| $I_{GSS}$                    | Gate-to-Source Leakage Reverse               | —    | —    | -100  |          | $V_{GS} = -20V$                                                                    |                                                                                                                                                  |
| $Q_g$                        | Total Gate Charge                            | 50   | —    | 125   | nC       | $V_{GS} = 10V$ , $I_D = 34A$                                                       |                                                                                                                                                  |
| $Q_{gs}$                     | Gate-to-Source Charge                        | 8    | —    | 22    |          | $V_{DS} = 0.5 \times \text{Max. Rating}$                                           |                                                                                                                                                  |
| $Q_{gd}$                     | Gate-to-Drain ("Miller") Charge              | 15   | —    | 65    |          | See Fig. 6 and 14                                                                  |                                                                                                                                                  |
| $t_{d(on)}$                  | Turn-On Delay Time                           | —    | —    | 35    | ns       | $V_{DD} = 50V$ , $I_D = 34A$ , $R_G = 2.35\Omega$                                  |                                                                                                                                                  |
| $t_r$                        | Rise Time                                    | —    | —    | 190   |          | See Fig. 11                                                                        |                                                                                                                                                  |
| $t_{d(off)}$                 | Turn-Off Delay Time                          | —    | —    | 170   |          |                                                                                    |                                                                                                                                                  |
| $t_f$                        | Fall Time                                    | —    | —    | 130   |          |                                                                                    |                                                                                                                                                  |
| $L_D$                        | Internal Drain Inductance                    | —    | 8.7  | —     | nH       | Measured from the drain lead, 6 mm (0.25 in.) from package to center of die.       | Modified MOSFET symbol showing the internal inductances.<br> |
| $L_S$                        | Internal Source Inductance                   | —    | 8.7  | —     |          | Measured from the source lead, 6 mm (0.25 in.) from package to source bonding pad. |                                                                                                                                                  |
| $C_{iss}$                    | Input Capacitance                            | —    | 3700 | —     | pF       | $V_{GS} = 0V$ , $V_{DS} = 25V$                                                     |                                                                                                                                                  |
| $C_{oss}$                    | Output Capacitance                           | —    | 1100 | —     |          | $f = 1.0$ MHz                                                                      |                                                                                                                                                  |
| $C_{rss}$                    | Reverse Transfer Capacitance                 | —    | 200  | —     |          | See Fig. 5                                                                         |                                                                                                                                                  |
| $C_{DC}$                     | Drain-to-Case Capacitance                    | —    | 12   | —     |          |                                                                                    |                                                                                                                                                  |



## IRFM150, JANTXV, JANTX-, 2N7224 Devices

### Source-Drain Diode Ratings and Characteristics

| Parameter |                                        | Min.                                                                                             | Typ. | Max. | Units         | Test Conditions                                                                                                                                                  |
|-----------|----------------------------------------|--------------------------------------------------------------------------------------------------|------|------|---------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| $I_S$     | Continuous Source Current (Body Diode) | —                                                                                                | —    | 34   | A             | Modified MOSFET symbol showing the integral Reverse p-n junction rectifier.<br> |
| $I_{SM}$  | Pulsed Source Current (Body Diode) ①   | —                                                                                                | —    | 136  |               |                                                                                                                                                                  |
| $V_{SD}$  | Diode Forward Voltage                  | —                                                                                                | —    | 1.8  | V             | $T_J = 25^\circ\text{C}$ , $I_S = 34\text{A}$ , $V_{GS} = 0\text{V}$ ④                                                                                           |
| $t_{rr}$  | Reverse Recovery Time                  | —                                                                                                | —    | 500  | nS            | $T_J = 25^\circ\text{C}$ , $I_F = 34\text{A}$ , $di/dt \leq 100\text{ A}/\mu\text{s}$ ④                                                                          |
| $Q_{RR}$  | Reverse Recovery Charge                | —                                                                                                | —    | 2.9  | $\mu\text{C}$ | $V_{DD} \leq 50\text{V}$                                                                                                                                         |
| $t_{on}$  | Forward Turn-On Time                   | Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_S + L_D$ . |      |      |               |                                                                                                                                                                  |

### Thermal Resistance

| Parameter  |                     | Min. | Typ. | Max. | Units | Test Conditions                            |
|------------|---------------------|------|------|------|-------|--------------------------------------------|
| $R_{thJC}$ | Junction-to-Case    | —    | —    | 0.83 | K/W ⑤ |                                            |
| $R_{thCS}$ | Case-to-Sink        | —    | 0.21 | —    |       | Mounting surface flat, smooth, and greased |
| $R_{thJA}$ | Junction-to-Ambient | —    | —    | 48   |       | Typical socket mount                       |

① Repetitive Rating: Pulse width limited by maximum junction temperature (see figure 9)  
Refer to current HEXFET reliability report

②  $V_{DD} = 25\text{V}$ , Starting  $T_J = 25^\circ\text{C}$ ,  
 $L \geq 200\text{ }\mu\text{H}$ ,  $R_G = 25\Omega$ ,  
Peak  $I_L = 34\text{A}$

③  $I_{SD} \leq 34\text{A}$ ,  $di/dt \leq 70\text{ A}/\mu\text{s}$ ,  
 $V_{DD} \leq BV_{DSS}$ ,  $T_J \leq 150^\circ\text{C}$   
Suggested  $R_G = 2.35\text{ }\Omega$

④ Pulse width  $\leq 300\text{ }\mu\text{s}$ ; Duty Cycle  $\leq 2\%$

⑤  $K/W = ^\circ\text{C}/W$   
 $W/K = W/^\circ\text{C}$

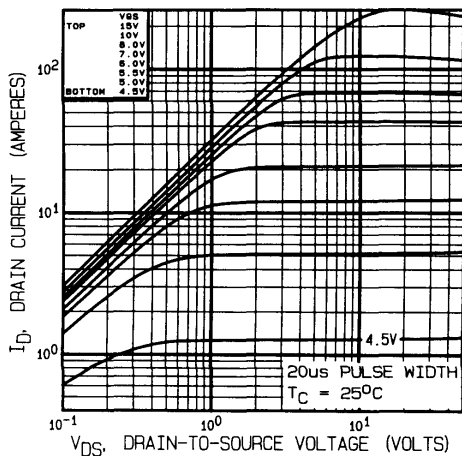


Fig. 1 — Typical Output Characteristics,  $T_C = 25^\circ\text{C}$

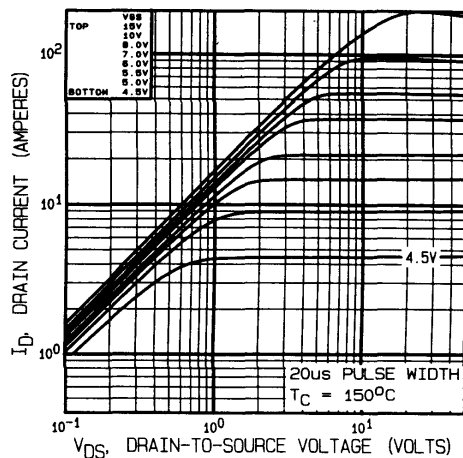


Fig. 2 — Typical Output Characteristics,  $T_C = 150^\circ\text{C}$

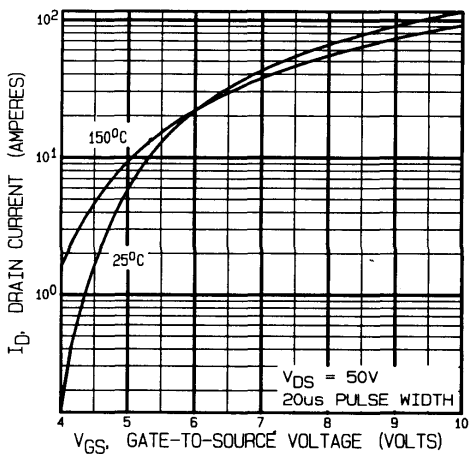


Fig. 3 — Typical Transfer Characteristics

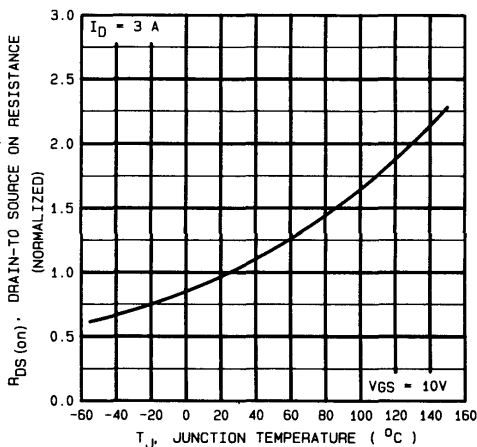


Fig. 4 — Normalized On-Resistance Vs. Temperature

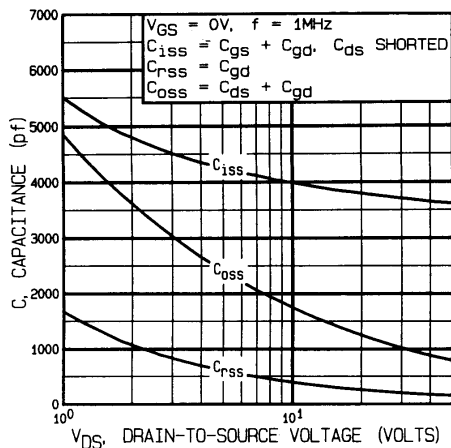


Fig. 5 — Typical Capacitance Vs. Drain-to-Source Voltage

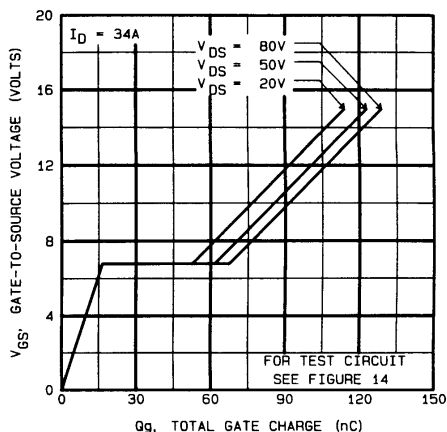


Fig. 6 — Typical Gate Charge Vs. Gate-to-Source Voltage

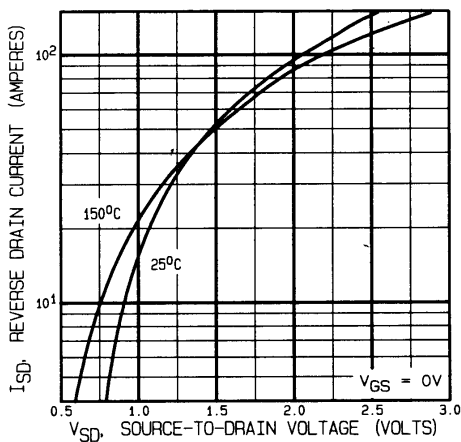


Fig. 7 — Typical Source-Drain Diode Forward Voltage

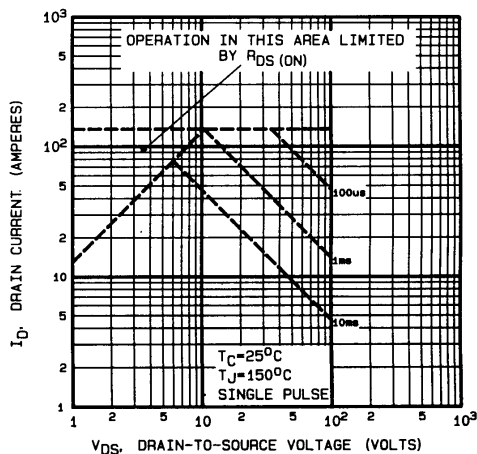


Fig. 8 — Maximum Safe Operating Area

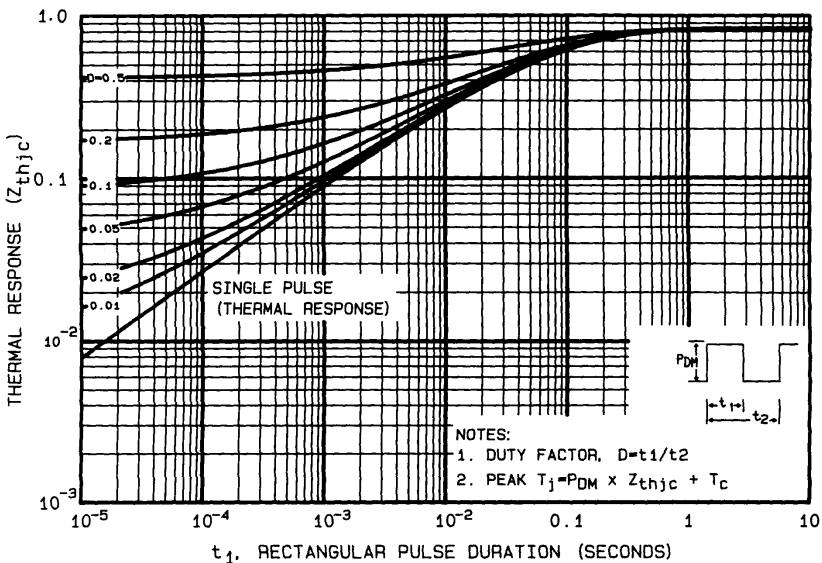


Fig. 9 — Maximum Effective Transient Thermal Impedance, Junction-to-Case Vs. Pulse Duration

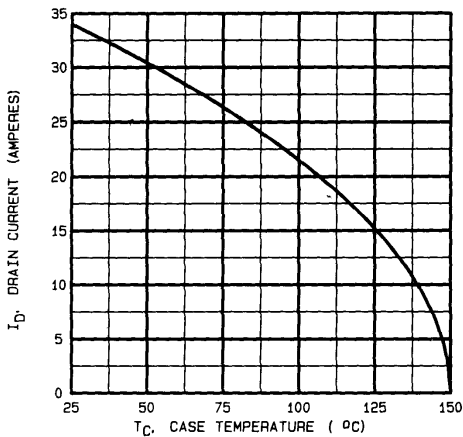


Fig. 10 — Maximum Drain Current Vs. Case Temperature

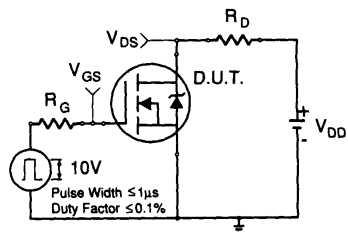


Fig. 11a — Switching Time Test Circuit

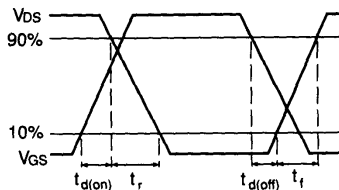


Fig. 11b — Switching Time Waveforms

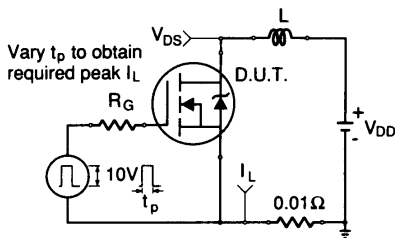


Fig. 12a — Unclamped Inductive Test Circuit

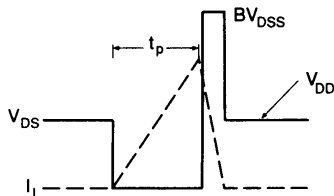


Fig. 12b — Unclamped Inductive Waveforms

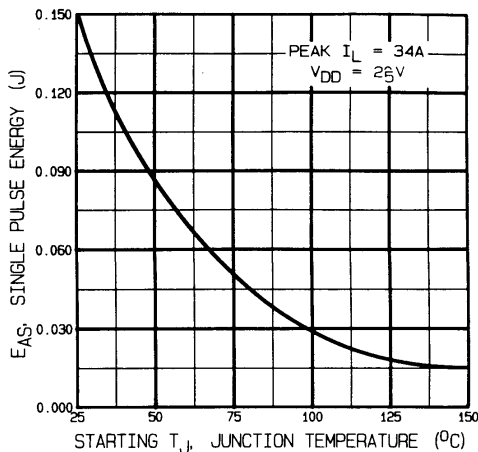


Fig. 12c — Maximum Avalanche Energy Vs. Starting Junction Temperature

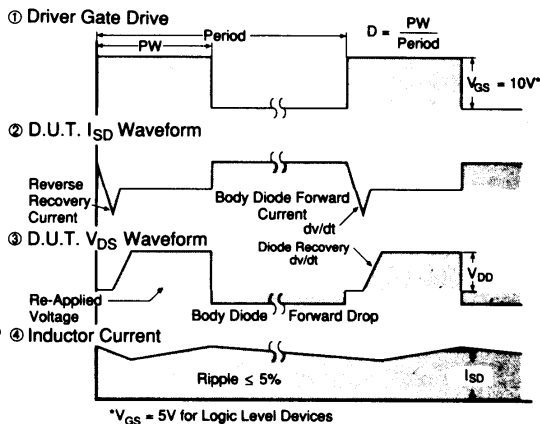
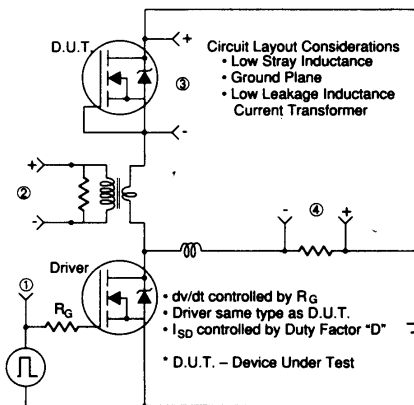


Fig. 13 — Peak Diode Recovery  $dv/dt$  Test Circuit

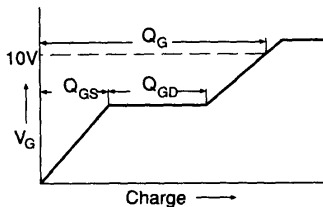


Fig. 14a — Basic Gate Charge Waveform

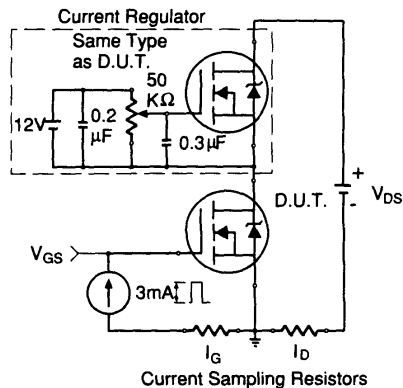


Fig. 14b — Gate Charge Test Circuit

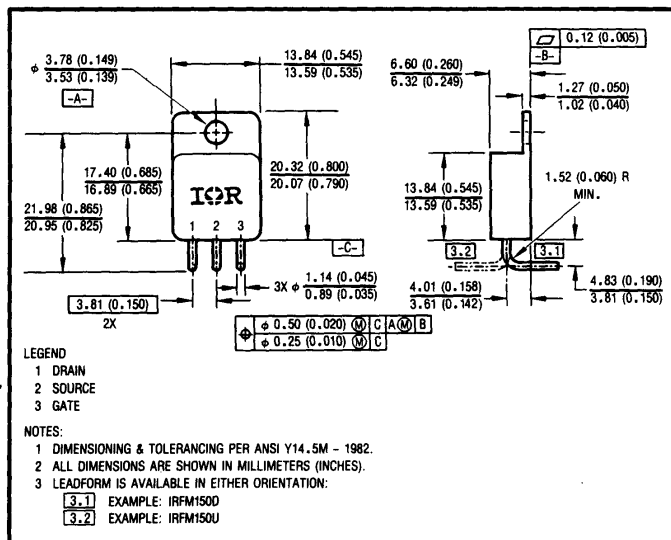


Fig. 15 — Optional Leadforms for Outline TO-254

## BERYLLIA WARNING PER MIL-S-19500

Packages containing beryllia shall not be ground, sandblasted, machined, or have other operations performed on them which will produce beryllia or beryllium dust. Furthermore, beryllium oxide packages shall not be placed in acids that will produce fumes containing beryllium.